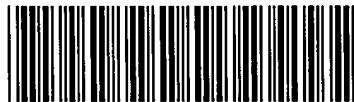


**Search Notes****Application/Control No.**

10/700,119

**Examiner**

Ren L. Yan

**Applicant(s)/Patent under Reexamination**

BECKER ET AL.

**Art Unit**

2854

**SEARCHED**

Class	Subclass	Date	Examiner
101	229		
	230		
	408		
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271	275		
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above search	7/25/05	R. Yan	
updated			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
interference search history printout	7/25/2005	R.Y.	